

RF Test Report

Applicant: Quectel Wireless Solutions Co., Ltd.

Address: Building 5, Shanghai Business Park Phase III (Area B), No.1016

Tianlin Road, Minhang District, Shanghai, China, 200233

Product: LTE Module

Model No.: EC21-A

Brand Name: QUECTEL

FCC ID: XMR201606EC21A

47 CFR Part 22

Standards: 47 CFR Part 24 47 CFR Part 27

Report No.: PD20240066RF01

Issue Date: 2024/06/11

Test Result: PASS *

* The above equipment has been tested and compliance with the requirement of the relative standards by Hefei Panwin Technology Co., Ltd.

Jerry Zhong

Reviewed By: Jerry Zhang

Ster Jug

Approved By: Alec Yang

Hefei Panwin Technology Co., Ltd.

Floor 1, Zone E, Plant 2#, Mingzhu Industrial Park, No.106 Chuangxin Avenue, High-tech Zone, Hefei City, Anhui Province, China TEL: +86-0551-63811775



Revision History

Report No.	Version	Description	Issue Date	Note
PD20240066RF01	01	Initial Report	2024/06/11	Valid

Remark:

Review this report and original report, this report just changing the parts according to the declaration letter from client. This test report has updated Radiated spurious emission for the device, and all other contents based on the original test report (Report No.: RKS170320003-00A) released by BACL on 2017/03/20.



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Test Summary

LTE Band 2 / UMTS Band II

No.	Test Case	FCC Rules	Limit	Verdict
1	RF Output Power & Effective	§2.1046,	EIRP ≤2 Watt	Refer to original
	Radiated Power	§24.232(c)		report
2	Peak-to-Average Ratio	§24.232(d)	≤13 dB	Refer to original report
3	Occupied Bandwidth	§2.1049	No limit.	Report Only
			≤ -13 dBm/1%*EBW, in 1	
4	Conducted Band Edge	§2.1051,	MHz bands immediately	Refer to original
4	Measurement	§24.238(a)	outside and adjacent to	report
			the frequency block.	
5	Spurious Emissions at Antenna Terminals	§2.1051, §24.238(a)	 ≤ -13 dBm/1 MHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges. 	Refer to original report
6	Radiated Spurious Emission	§2.1053, §24.238(a)	≤ -13 dBm/1 MHz.	PASS
7	Frequency Stability	§2.1055 §24.235	Within authorized bands of operation/frequency block.	Refer to original report



LTE Band 4 / UMTS Band IV

No.	Test Case	FCC Rules	Limit	Verdict
1	RF Output Power & Effective Radiated Power	§2.1046, §27.50(d)(4)	EIRP ≤ 1 Watt	Refer to original report
2	Peak-to-Average Ratio	§27.50(d)(5)	≤13 dB	Refer to original report
3	Occupied Bandwidth	§2.1049	No limit.	Report Only
4	Conducted Band Edge Measurement	§2.1051, §27.53(h)	 ≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block. 	Refer to original report
5	Spurious Emissions at Antenna Terminals	§2.1051, §27.53(h)	 ≤ -13 dBm/1 MHz, from 9 kHz to 10th harmonics but outside authorized operating frequency ranges. 	Refer to original report
6	Radiated Spurious Emission	§2.1053, §27.53(h)	≤ -13 dBm/1 MHz.	PASS
7	Frequency Stability	§2.1055 §27.54	Within authorized bands of operation/frequency block.	Refer to original report



UMTS Band V

No.	Test Case	FCC Rules	Limit	Verdict
1	RF Output Power & Effective	§2.1046	ERP ≤ 7 Watt	Refer to original
	Radiated Power	§22.913 (a)(5)		report
2	Peak-to-Average Ratio	§22.913 (d)	≤13 dB	Refer to original report
3	Occupied Bandwidth	§2.1049	No limit.	Report Only
			≤ -13 dBm/1%*EBW, in 1	
4	Conducted Band Edge	§2.1051	MHz bands immediately	Refer to original
4	Measurement	§22.917 (a)	outside and adjacent to	report
			the frequency block.	
			FCC: ≤ -13 dBm/100 kHz,	
	Spurious Emissions at Antenna	§2.1051	from 9 kHz to 10 th	Refer to original
5	Terminals	§22.917(a)	harmonics but outside	report
	Terrindis	322.917(d)	authorized operating	report
			frequency ranges.	
6	Radiated Spurious Emission	§2.1053	FCC: ≤ -13 dBm/100 kHz.	PASS
		§22.917(a)		FAGO
7	Frequency Stability	§2.1055	< ±2.5 ppm	Refer to original
		§22.355	< ±2.5 ppm	report



LTE Band 12

No.	Test Case	FCC Rules	Limit	Verdict
1	RF Output Power & Effective Radiated Power	§2.1046, §27.50(c)(10)	ERP ≤ 3 Watt	Refer to original report
2	Peak-to-Average Ratio		≤13 dB	Refer to original report
3	Occupied Bandwidth	§2.1049	No limit.	Report Only
4	Conducted Band Edge Measurement	§2.1051, §27.53(g)	For operations in the 600 MHz band and the 698–746 MHz band, the power of any emission outside a licensee's frequency band(s) of operation shall be attenuated below the transmitter power (P) within the licensed band(s) of operation, measured in watts, by at least 43 + 10 log (P) dB. Compliance with this provision is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kilohertz or greater. However, in the 100 kilohertz bands immediately outside and adjacent to a licensee's frequency block, a resolution bandwidth of at least 30 kHz may be employed.	Refer to original report
5	Spurious Emissions at Antenna Terminals	§2.1051, §27.53(g)	FCC: ≤ -13 dBm/100 kHz, from 9 kHz to 10 th harmonics but outside authorized operating frequency ranges.	Refer to original report
6	Radiated Spurious Emission	§2.1053, §27.53(g)	FCC: ≤ -13 dBm/100 kHz.	PASS
7	Frequency Stability	§2.1055 §27.54	Within authorized bands of operation/frequency block.	Refer to original report

Radiated detection date: 2024/05/20

Date of Sample Received: 2024/05/16

• We, Hefei Panwin Technology Co., Ltd., would like to declare that the tested sample has been evaluated in accordance with the procedures given in applied standard(s) in **Section 2.4** of this report and shown compliance with the applicable technical standards.

All indications of PASS/FAIL in this report are based on interpretations and/or observations of test results.

Measurement Uncertainties were not taken into account and are published for informational purposes only.

1 Test Laboratory

1.1 Notes of the Test Report

This report is invalid without signature of auditor and approver or with any alterations. The report shall not be partially reproduced without written approval of the testing company. Entrusted test results are only responsible for incoming samples. If there is any objection to the testing report, it shall be raised to the testing company within 15 days from the date of receiving the report. In the test results, "NA" means "not applicable", and the test items marked with " Δ " are subcontracted projects.

1.2 Test Facility

FCC (Designation Number: CN1361, Test Firm Registration Number: 473156)

Hefei Panwin Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform measurements.

A2LA (Certificate Number: 6849.01)

Hefei Panwin Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform measurement.

1.3 Testing Laboratory

Company Name Hefei Panwin Technology Co., Ltd.		
Address	Floor 1, Zone E, Plant 2#, Mingzhu Industrial Park, No.106 Chuangxin Avenue, High-tech Zone, Hefei City, Anhui Province,China	
Telephone	+86-0551-63811775	
Post Code	230031	

2 General Description of Equipment under Test

2.1 Details of Application

Applicant	Quectel Wireless Solutions Co., Ltd.		
Applicant Address	Building 5, Shanghai Business Park Phase III (Area B), No.1016 Tianlin		
Applicant Address	Road, Minhang District, Shanghai, China, 200233		
Manufacturer	Quectel Wireless Solutions Co., Ltd.		
Manufacturar Address	Building 5, Shanghai Business Park Phase III (Area B), No.1016 Tianlin		
Manufacturer Address	Road, Minhang District, Shanghai, China, 200233		



2.2 Details of EUT

Product		LTE M	lodule						
Model		EC21-	A						
Series Model		EC21-	A MINI	PCIE					
Model Differe	ence(s)	Only t	he conr	nector ir	terface	is diffe	rent for	the marketing re	quirement.
Hardware Ver	rsion	R2.0							
Software Ver	sion	EC21AFAR05A07M4G							
SN				1PQ21E 2Q21DS					
UMTS Specif	ication								
Single Band		WCDN	/A Ban	d II, IV,	V				
Power Class	for UMTS	PC3							
Type of Modu	Ilation	Supports QPSK, 16QAM and 64QAM modulations							
E-UTRA Spec	ification								
Single Band		FDD Band: 2, 4, 12							
Power Class	for LTE	PC3							
Type of Modu	llation		PSK, 16 PSK, 16	6qam 6qam, (64QAM				
Antenna Type	9	⊠ Ext	ernal		∃ Integr	ated			
Antenna Gair	ı	WCDN	VCDMA Band II: 1.59dBiLTE Band 2: 1.59dBiVCDMA Band IV: 2.00dBiLTE Band 4: 2.00dBiVCDMA Band V: 2.13dBiLTE Band 12: 3.26dBi						
	SISO Band	Supp	Supported Channel Bandwidth (MHz)				MHz)		
	SISO Band	1.4	3	5	10	15	20	Tx (MHz)	Rx (MHz)
-	WCDMA Band II	-	-	v	-	-	-	1850 to 1910	1930 to 1990
Frequency	WCDMA Band IV	-	-	v	-	-	-	1710 to 1755	2110 to 2155
Band(s)	WCDMA Band V	-	-	v	-	-	-	824 to 849	869 to 894
	LTE Band 2	v	v	v	v	v	v	1850 to 1910	1930 to 1990
	LTE Band 4	v	v	v	v	v	v	1710 to 1755	2110 to 2155
	LTE Band 12		v	v	v	-	-	699 to 716	729 to 746
	clared of product specification and the manufacturer takes								•



Support Equipment							
Equipment Manufacturer Description Model Serial Num							
EVB	QUECTEL	1	/	/			
Power Adapter	1	5V/2A	CLS-050200	/			
USB cable	UGREEN	1	1	/			
External Antenna	SDN	1	4G-LTE	SAA30968A			



2.3 Frequency List of Low/Middle/High Channels

WCDMA Band II Channel and Frequency List								
BW [MHz]	BW [MHz] Channel/Frequency(MHz) Lowest Middle Highest							
	Channel	9262	9400	9538				
5	Frequency	1852.4	1880.0	1907.6				

WCDMA Band IV Channel and Frequency List							
BW [MHz] Channel/Frequency(MHz) Lowest Middle Highest							
F	Channel	1312	1413	1513			
5	Frequency	1712.4	1732.6	1752.6			

WCDMA Band V Channel and Frequency List				
BW [MHz]	Channel/Frequency(MHz)	Lowest	Middle	Highest
F	Channel	4132	4182	4233
5	Frequency	826.4	836.4	846.6

LTE Band 2 Channel and Frequency List				
BW [MHz]	Channel/Frequency(MHz)	Lowest	Middle	Highest
1.4	Channel	18607	18900	19193
1.4	Frequency	1850.7	1880	1909.3
3	Channel	18615	18900	19185
5	Frequency	1851.5	1880	1908.5
F	Channel	18625	18900	19175
5	Frequency	1852.5	1880	1907.5
10	Channel	18650	18900	19150
10	Frequency	1855	1880	1905
15	Channel	18675	18900	19125
15	Frequency	1857.5	1880	1902.5
20	Channel	18700	18900	19100
20	Frequency	1860	1880	1900

LTE Band 4 Channel and Frequency List				
BW [MHz]	Channel/Frequency(MHz)	Lowest	Middle	Highest
1 4	Channel	19957	20175	20393
1.4	Frequency	1710.7	1732.5	1754.3
3	Channel	19965	20175	20385
5	Frequency	1711.5	1732.5	1753.5
5	Channel	19975	20175	20375
5	Frequency	1712.5	1732.5	1752.5
10	Channel	20000	20175	20350



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	Frequency	1715	1732.5	1750
15	Channel	20025	20175	20325
15	Frequency	1717.5	1732.5	1747.5
20	Channel	20050	20175	20300
20	Frequency	1720	1732.5	1745

LTE Band 12 Channel and Frequency List				
BW [MHz]	Channel/Frequency(MHz)	Lowest	Middle	Highest
1.4	Channel	23017	23095	23173
1.4	Frequency	699.7	707.5	715.3
3	Channel	23025	23095	23165
3	Frequency	700.5	707.5	714.5
5	Channel	23035	23095	23155
5	Frequency	701.5	707.5	713.5
10	Channel	23060	23095	23130
10	Frequency	704	707.5	711



2.4 Applied Standards

According to the specifications of the manufacturer, the EUT must comply with the requirements of the following standards:

47 CFR Part 2 47 CFR Part 22 47 CFR Part 24 47 CFR Part 27 ANSI C63.26-2015 FCC KDB 971168 D01 Power Meas License Digital Systems v03r01 FCC KDB 412172 D01 Determining ERP and EIRP v01r01

Remark: All test items were verified and recorded according to the standards and without any deviation during the test.



3 Test Condition

3.1 Test Environmental Conditions

During testing, environmental conditions are described below.

Normal Cor	nfiguration	Extreme Configuration		
Voltage	3.8V	Voltage	High: 4.3V	Low: 3.3V

3.2 Test Configuration

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture). The worst cases were recorded in this report.

Radiated measurements are performed by rotating the EUT in three different orthogonal test planes (Z, X, Y axis), receiver antenna polarization (horizontal and vertical), the worst emission was found in 'Z' position and the worst case was recorded.



3.3 Equipment List

Instrument	Manufacturer	Model	Asset No.	Cal. Interval	Cal. Due Date
Conducted					
Base Station Simulator	R&S	CMW500	PWC0052	1 Year	2024/10/11
Spectrum Analyzer	KEYSIGHT	N9020B	PWC0047	1 Year	2024/10/10
DC Power	KEYSIGHT	E3640A	PWC0046	1 Year	2024/10/11
Climate Chamber	Boyi	B-T-48C	PWC0051	1 Year	2024/11/12
Shielded Chamber	Mao Rui	MR534	PWC0041	3 Years	2026/08/26
Coupling unit	COM-MW	Directional coupler	1	1	1
Test Software	Tonscend	JS1120 V3.1.46	/	/	/
		Radiated			
Receiver	R&S	ESR7	PWB0023	1 Year	2024/10/11
Spectrum Analyzer	R&S	FSV3044	PWB0024	1 Year	2024/10/11
TRILOG Broadband Antenna	Schwarzbeck	VULB9162	PWB0029	1 Year	2024/10/14
Double-Ridged Guide Antenna	ETS-Lindgren	3117	PWB0031	1 Year	2024/10/12
Loop Antenna	R&S	HFH2-Z2E	PWB0026	1 Year	2024/10/21
k Type Horn Antenna	Steatite Antennas	QMS-00880	PWB0035	1 Year	2024/10/17
Horn Antenna	Steatite Antennas	QMS-00208	PWB0033	1 Year	2024/10/21
Pre-Amplifier	R&S	SCU08F1	PWB0030	1 Year	2024/10/11
Pre-Amplifier	R&S	SCU40F1	PWB0036	1 Year	2024/10/11
Pre-Amplifier	R&S	OSP220 (OSP-B155G)	PWB0042	1 Year	2024/10/13
Pre-Amplifier	R&S	SCU18F	PWB0034	1 Year	2024/10/11
Pre-Amplifier	COM-MW	DLNA8	PWB0094	1 Year	2024/11/08
Anechoic Chamber	ETS.LINDGREN	Fact 3-2m	PWB0003	3 Years	2026/06/05
Test Software	R&S	ELEKTRA 4.20.2	1	1	/



3.4 Test Uncertainty

No.	Parameter	Uncertainty
1	Maximum transmit power	0.677dB
2	Frequency error	37.064Hz
3	Bandwidth occupied	5.9kHz
		10Hz-3.5GHz: 0.982dB
	Emission enurious, Band edge and DADD	3.5GHz-18GHz: 1dB
4	Emission spurious, Band edge and PAPR	18GHz-26.5GHz: 0.777dB
		26.5GHz-40GHz: 1.066dB
F	Dedicted Courieus Emission	Below 1GHz: 4.88 dB
5	Radiated Spurious Emission	Above 1GH: 5.06 dB
6	Temperature	3°C
7	Humidity	1.3 %
8	Supply voltages	0.006 V



4 Test Items Description

Ambient condition

Shielded Chamber

Anechoic Chamber

Temperature [°C]	20.1 to 25.7
Humidity [%RH]	39 to 46
Pressure [kPa]	100.2 to 102.5
Temperature [°C]	23.7 to 25.3
Humidity [%RH]	43 to 48
Pressure [kPa]	100.8 to 100.9

4.1 RF Output Power & Effective (Isotropic) Radiated Power

Methods of Measurement

Base Station Simulator was used to establish communication with the EUT. Its parameters were set to force the EUT transmitting at maximum output power. The measured power in the radio frequency on the transmitter output terminals shall be reported.

According to KDB 412172 D01 Power Approach,

EIRP = PT + GT - LC, ERP = EIRP - 2.15, where

PT = transmitter output power in dBm

GT = gain of the transmitting antenna in dBi

LC = signal attenuation in the connecting cable between the transmitter and antenna in dB

Test Setup

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0000	

1. The testing follows ANSI C63.26 Section 5.2.

2. The transmitter output port was connected to the base station simulator.

3.Set EUT at maximum power through the base station simulator

4.Select lowest, middle, and highest channels for each band and different modulation.

5.Measure and record the power level from the system simulator.

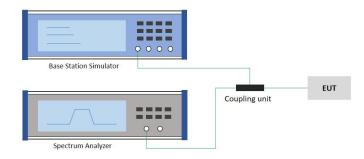


4.2 EIRP Power Density

Methods of Measurement

Measurement Procedure: C63.26 -2015 section 5.2.4

Test Setup



1.Set instrument center frequency to OBW center frequency.

2.Set span to at least 1.5 times the OBW.

3.Set the RBW to the specified reference bandwidth (often 1 MHz).

4.Set VBW \geq 3 × RBW.

5.Detector = RMS (power averaging).

6.Ensure that the number of measurement points in the sweep \geq 2 × span/RBW.

7.Sweep time = auto couple.

8.Employ trace averaging (RMS) mode over a minimum of 100 traces.

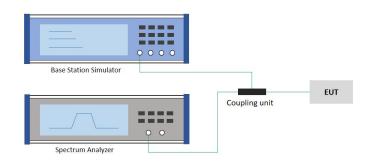
9.Use the peak marker function to determine the maximum amplitude level within the reference bandwidth (PSD).

4.3 Peak-to-Average Ratio

Methods of Measurement

Power Complementary Cumulative Distribution Function (CCDF) curves provide a means for characterizing the power peaks of a digitally modulated signal on a statistical basis. A CCDF curve depicts the probability of the peak signal amplitude exceeding the average power level. Most contemporary measurement instrumentation include the capability to produce CCDF curves for an input signal provided that the instrument's resolution bandwidth can be set wide enough to accommodate the entire input signal bandwidth.

Test Setup



1. The testing follows ANSI C63.26 Section 5.2.3.4 (CCDF).

2. The EUT was connected to spectrum and system simulator via a coupling unit.

3.Set the CCDF (Complementary Cumulative Distribution Function) option in spectrum analyzer.

4.The highest RF powers were measured and recorded the maximum PAPR level associated with a probability of 0.1 %.

5.Record the deviation as Peak to Average Ratio.

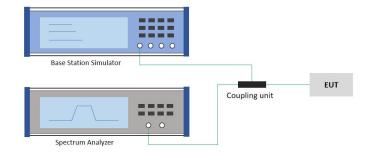
4.4 Occupied Bandwidth

Methods of Measurement

The occupied bandwidth is the width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5% of the total mean transmitted power.

The 26 dB emission bandwidth is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated 26 dB below the maximum in-band spectral density of the modulated signal. Spectral density (power per unit bandwidth) is to be measured with a detector of resolution bandwidth equal to approximately 1.0% of the emission bandwidth.

Test Setup



The testing follows ANSI C63.26 Section 5.4.

The EUT was connected to spectrum analyzer and system simulator via a coupling unit.

The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the spectrum analyzer shall be between two and five times the anticipated OBW.

The nominal resolution bandwidth (RBW) shall be in the range of 1 to 5 % of the anticipated OBW, and the VBW shall be at least 3 times the RBW.

Set the detection mode to peak, and the trace mode to max hold.

Determine the reference value: Set the EUT to transmit a modulated signal. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace.

(this is the reference value).

Determine the '-26 dB down amplitude' as equal to (Reference Value - X).

Place two markers, one at the lowest and the other at the highest frequency of the envelope of the spectral display such that each marker is at or slightly below the '–X dB down amplitude' determined in step 6. If a marker is below this '-X dB down amplitude' value it shall be placed as close as possible to this value. The OBW is the positive frequency difference between the two markers.

Use the 99 % power bandwidth function of the spectrum analyzer and report the measured bandwidth.

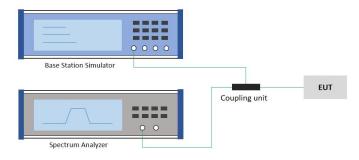
4.5 Conducted Band Edge Measurement

Methods of Measurement

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyser, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The tests were performed at two frequencies (low channel and high channel). In the 1MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of 100kHz or 1% of the emission bandwidth of the fundamental emission of the transmitter may be employed. The EUT emission bandwidth is measured as the width of the signal between two points, outside of which all emission are attenuated at least 26dB below the transmitter power. The video bandwidth of the spectrum analyzer was set at thrice the resolution bandwidth. Detector Mode was set to RMS.

Test Setup



1. The testing follows ANSI C63.26 section 5.7

2. The EUT was connected to spectrum analyzer and system simulator via a coupling unit.

3. The band edges of low and high channels for the highest RF powers were measured.

4.Set RBW >= 1% EBW in the 1MHz band immediately outside and adjacent to the band edge.

5.Beyond the 1 MHz band from the band edge, RBW=1MHz was used or a narrower RBW was used and the measured power was integrated over the full required measurement bandwidth of 1 MHz.

6.Set spectrum analyzer with RMS detector.

7. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

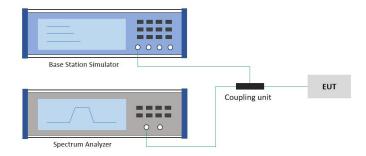
4.6 Spurious Emissions at Antenna Terminals

Methods of Measurement

Measurement Procedure: FCC KDB 971168 D01 V03r01 Section 6.0

The transmitter output was connected to a calibrated coaxial cable, attenuator and Spectrum analyzer, the other end of which was connected to a Base Station Simulator. The Base Station Simulator was set to force the EUT to its maximum power setting. The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least 43 + 10 log(P) dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 1 MHz or greater. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Test Setup



1. The testing follows ANSI C63.26 section 5.7

2. The EUT was connected to spectrum analyzer and system simulator via a coupling unit.

3. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement.

4. The middle channel for the highest RF power within the transmitting frequency was measured.

5. The conducted spurious emission for the whole frequency range was taken.

6.Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz.

7.Set spectrum analyzer with RMS detector.

8. Taking the record of maximum spurious emission.

9. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

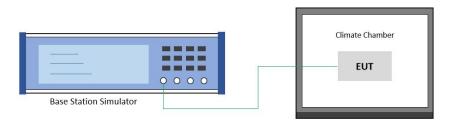
Note: As described in Section C63.26 4.2.3: Generally, the measurement must be corrected by adding 10 log [(reference bandwidth) / (resolution or measurement bandwidth)] to the measured value (such bandwidth scaling is limited to cases where the measurement bandwidth used to perform the measurement is less than the reference bandwidth). Therefore, the converted limit value is the standard limit value minus the conversion factor.

4.7 Frequency Stability

Methods of Measurement

The frequency stability shall be measured by variation of ambient temperature and variation of primary supply voltage to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

Test Setup



Test Procedures for Temperature Variation

1. The testing follows ANSI C63.26 section 5.6.4

2. The EUT was set up in the thermal chamber and connected with the system simulator.

3.With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute.

4.With power OFF, the temperature was raised in 10°C step up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute.

Test Procedures for Voltage Variation

1.The testing follows ANSI C63.26 section 5.6.5

2. The EUT was placed in a temperature chamber at 20±5°C and connected with the system simulator.

3. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value for other than hand carried battery equipment.

4.For hand carried, battery powered equipment, reduce the primary ac or dc supply voltage to the battery operating end point, which shall be specified by the manufacturer.

5. The variation in frequency was measured for the worst case.



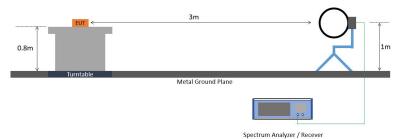
4.8 Radiated Spurious Emission

Methods of Measurement

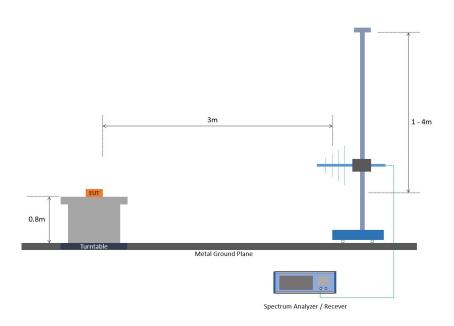
The radiated spurious emission was measured by substitution method according to ANSI C63.26. The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitter power (P) by a factor of at least 43 + 10 log (P) dB.

The spectrum is scanned from 30 MHz up to a frequency including its 10th harmonic.

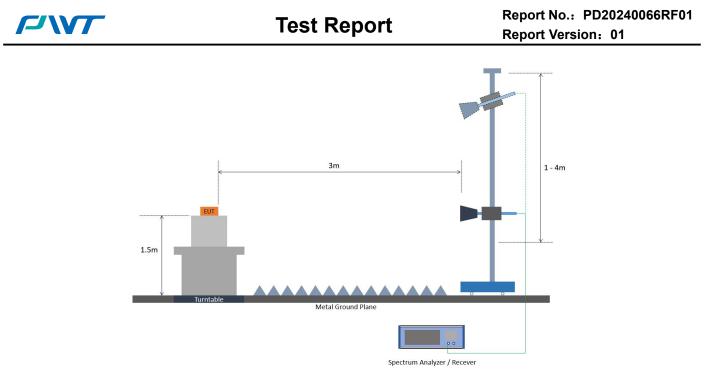
Test Setup



For radiated test below 30MHz



For radiated test from 30MHz to 1GHz



For radiated test above 1GHz

1. The testing follows ANSI C63.26 Section 5.5

2.The EUT was placed on a turntable with 0.8 meter height for frequency below 1GHz and 1.5 meter height for frequency above 1GHz respectively above ground.

3. The EUT was set 3 meters from the receiving antenna mounted on the antenna tower.

4. The table was rotated 360 degrees to determine the position of the highest spurious emission.

5. The height of the receiving antenna is varied between 1m to 4m to search the maximum spurious emission for both horizontal and vertical polarizations.

6.During the measurement, the system simulator parameters were set to force the EUT transmitting at maximum output power.

7.Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.

8.A horn antenna was substituted in place of the EUT and was driven by a signal generator.

9. Tune the output power of signal generator to the same emission level with EUT maximum spurious emission.

10.EIRP (dBm) = S.G. Power - Tx Cable Loss + Tx Antenna Gain

11.ERP (dBm) = EIRP - 2.15

12. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

Remark: The low frequency, which started from 9 kHz to 30MHz, was pre-scanned and the result which was 20dB lower than the limit line was not reported.



Appendixes

External Photograph	Refer to "Attachment A.1: External Photograph" file.
Internal Photograph	Refer to "Attachment A.2: Internal Photograph" file.
Test Setup Photograph	Refer to "Attachment A.4: RF Test Setup Photograph" file.

Test Results of Radiated Test

Radiation spurious test data	Refer to "Attachment C" file.
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****** End of the Report ******